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A -1.8V to 0.9V Body Bias, 60 GOPS/W 4-core Cluster in low-power 28nm UTBB FD-SOI technology

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Abstract

A 4-core cluster fabricated in low power 28nm UTBB FD-SOI conventional well technology is presented. The SoC architecture enables the processors to operate “on-demand” on a 0.44V (1.8MHz) to 1.2V (475MHz) supply voltage wide range and -1.2V to 0.9V body bias wide range achieving the peak energy efficiency of 60 GOPS/W, (419µW, 6.4MHz) at 0.5V with 0.5V forward body bias. The proposed SoC energy efficiency is 1.4x to 3.7x greater than other low-power processors with comparable performance.

Introduction

Ultra-low power operation and extreme energy efficiency are strong requirements for a number of high-growth Internet-of-Things applications requiring near-sensor processing. A promising approach to achieve major energy efficiency improvements is near-threshold computing. However, frequency degradation due to aggressive voltage scaling may not be acceptable for performance-constrained applications. The SoC presented in this work exploits multi-core parallelism with explicitly-managed shared L1 memory to overcome performance degradation at low voltage, while keeping the flexibility typical of instruction processors. Moreover, enabling the cores to operate on-demand over a wide supply voltage and body bias ranges allows to achieve high energy efficiency over a wide spectrum of computational demands.

Conventional well UTBB FD-SOI technology

Past work on UTBB FD-SOI processors focused on the high-performance flavor of the technology (flip well) where aggressive forward body-biasing led to major operating frequency boost \cite{1}. In this work, we focus for the first time on low-power multi-processor design based on low-leakage FD-SOI transistors where NMOS and PMOS are on P-well and N-well, a theoretical reverse body-biasing (RBB) up to -3V and a forward body-biasing (FBB) up to [VDD/2 + 300 mV] can be applied (Fig. 1). As opposed to the flip well flavor of the technology, supporting both RBB and FBB conventional well enables flexible management of leakage power and it is very well suited for low-power applications \cite{1}. Moreover, when applied to conventional well, FBB is useful to achieve maximum energy efficiency and not only as a speed-boosting method (as opposed to the flip-well flavor).

SoC Architecture

The SoC consists of a cluster of four cores and 16 kB of L2 memory (Fig. 2). The cores, featuring 1K instruction cache each, are based on a highly power optimized microarchitecture implementing the OpenRISC ISA. GCC and LLVM toolchains are available for the core, OpenMP 3.0 is supported on top of bare-metal parallel runtime. Energy efficiency is boosted by using a carefully tuned pipeline depth to reduce register and clocking overhead, while the data-path is area-optimized to reduce leakage. To avoid memory coherency overhead and increase energy efficiency the cores do not have private data caches, while they share a L1 multi-banked Tightly Coupled Data Memory (TCDM) acting as an explicitly managed data scratchpad memory. The TCDM features 8 word-level interleaved 2kB SRAM banks connected to the processors through a non-blocking interconnect to minimize banking conflict probability. The whole memory space (L1, L2, memory mapped peripherals) is visible to all the cores of the cluster (Global Address Space architecture). L2 cluster memory latency is managed by a DMA featuring 10 cycles programming latency, up to 16 outstanding transactions and 4 physical channels for DMA control (one per core, thereby completely eliminating DMA control port contention). The DMA has a direct connection to the TCDM through 4 dedicated ports on the TCDM interconnect. This eliminates the need for data buffering in the DMA engine, which is very expensive in terms area and power. Starvation of the cores is prevented thanks to the x2 banking factor and fair arbitration.
Fine-Grained Body Biasing

To enable the SoC to achieve high energy efficiency for a wide range of workloads and to reduce the overhead of unused cores during the execution of sequential code, the cluster features on-demand shut down of cores by means of fine-grained partitioning into 6 regions with separate clock trees and isolated wells (Fig. 2). The memory cuts that implement L2 memory, TCDM and IS are based on standard SRAMs without support for body bias. 6 digitally controlled body bias multiplexers (BBMUXes) select the polarization of the P-well and the N-well of each region (vdds, gnds) choosing between two couples of global voltages (vdds_rbb, gnds_rbb; vdds_fbb, gnds_fbb) thus enabling per-region body-bias state selection (FBB or RBB). In contrast to DVFS and power gating approaches, this architecture has minimal overhead in terms of area (less than 1%) and does not require level shifters and power grid isolation. The measured switching time between the two different body-bias states is lower than 30ns. Fig. 3 and Fig. 4 shows the measured impact of FBB and RBB on the operating frequency and leakage power of the body biased regions. In the near-threshold operating range, where the body bias technique is more effective, RBB provides up to 10x reduction of leakage power, while FBB provides an increase of up to 2.5x of operating frequency. This makes body biasing an excellent knob to modulate the leakage performance trade-off of the cluster regions enabling ultra-fast transitions between the high energy efficient active and the low leakage states.

Experimental Results

Fig. 5 shows the frequency, total power consumption, and leakage power consumption of the chip.

<table>
<thead>
<tr>
<th>Voltage [V]</th>
<th>Max Frequency [MHz]</th>
<th>Total Power @ Max Frequency [mW]</th>
<th>Leakage Power @ 25°C [µW]</th>
</tr>
</thead>
<tbody>
<tr>
<td>0.5</td>
<td>3.1</td>
<td>0.23</td>
<td>25.9</td>
</tr>
<tr>
<td>0.6</td>
<td>25.3</td>
<td>2.00</td>
<td>31.4</td>
</tr>
<tr>
<td>0.7</td>
<td>86.2</td>
<td>8.36</td>
<td>56.5</td>
</tr>
<tr>
<td>0.8</td>
<td>168.3</td>
<td>20.41</td>
<td>114.7</td>
</tr>
<tr>
<td>0.9</td>
<td>254.9</td>
<td>38.21</td>
<td>241.5</td>
</tr>
<tr>
<td>1.0</td>
<td>337.6</td>
<td>61.73</td>
<td>496.4</td>
</tr>
<tr>
<td>1.1</td>
<td>360</td>
<td>87.39</td>
<td>760.8</td>
</tr>
<tr>
<td>1.2</td>
<td>452</td>
<td>119.72</td>
<td>1693.3</td>
</tr>
</tbody>
</table>

Fig. 6 Energy efficiency in the frequency range [0MHz; 100MHz].

Fig. 7 Leakage current as function of the supply voltage in the temperature range [-40°C; 150°C].
Fig. 8 Impact of power management applied to the idle regions of the cluster when running on a single core. The power considered for calculation of energy efficiency includes the silicon area that can be body biased (i.e. it does not include power consumption of SRAMs).

Fig. 9 Maximum measured frequency of 60 samples at Vdd=0.6V. Compensation of die to die frequency variation utilizing forward body bias to reach a frequency larger than the target frequency of 25 MHz.

Figure 8 highlights the effectiveness of the “on-demand” deactivation of the regions of the cluster by means of clock gating and RBB, when executing sequential code on a single core. This technique can be exploited to increase the energy efficiency when parallel execution over multiple cores is not required by the application (i.e., for low workloads), or during the execution of sequential portions of code that cannot be parallelized, due to the Amdahl’s law. Eliminating the overhead caused by the idle regions of the cluster it is possible to increase the energy efficiency of the chip by up to 160%.

Although low-voltage operation causes large variation of the maximum operating frequency from die to die, UTBB FD-SOI technology provides an effective knob to fully compensate such variation, namely FBB. The maximum operating frequency measured on 60 chip samples at VDD=0.6V ranges between 19 MHz and 28 MHz, 25 MHz being the average frequency. As shown in Fig. 9 applying FBB ranging from 0.1V to 0.3V to the slow chips allows to bring the maximum frequency of all the 60 dies over the target frequency of 25 MHz. Compensation is achieved with no increase of dynamic power (as opposed to compensation through supply voltage).

A micrograph of the SoC and a comparison with other low-power processors are shown in Fig. 10 and Fig. 11. The proposed SoC energy efficiency (GOPS/W) is 1.4x to 3.7x larger than other processors optimized for near-threshold operation with comparable GOPS [3][4]. The chip also outperforms by 144x while achieving a comparable energy efficiency with respect to a leading-edge near-threshold RISC single-issue 16-bit processor optimized for extremely low power applications [2]. Energy efficiency surpasses previously works by more than 43%, when considering only the power consumed in the core silicon area that can be body biased.

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References